

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination KWON, WON TAIK	
			Examiner Chandra Chaudhari	Art Unit 2891	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,037,236	03-2000	Jang, Syun-Ming	438/401
*	C	US-6,136,662	10-2000	Allman et al.	438/427
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
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